Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/664,931	CHAE ET AL.
Examiner	Art Unit
Richard H. Kim	2871

SEARCHED						
SEARCHED						
Class	Subclass	Date	Examiner			
349	42,43,137	8/8/2005	RHK			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH I (INCLUDING SEAR	CH S	S FRATEGY)
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East Search (see printout)		8/8/2005	RHK
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